

**Notice of References Cited**

Application/Control No.

09/989,247

Applicant(s)/Patent Under  
Reexamination  
HENTSCHEL ET AL.

Examiner

Trang U. Tran

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,507,372 B1	01-2003	Kim, Yeong-taeg	348/630
*	B	US-6,021,216 A	02-2000	Sathe et al.	382/166
*	C	US-5,457,494 A	10-1995	Suga et al.	348/229.1
*	D	US-5,099,329 A	03-1992	Oyama et al.	348/620
*	E	US-5,144,434 A	09-1992	Yamashita et al.	348/613
*	F	US-4,953,032	08-1990	Suzaki et al.	348/722
	G	US-6,285,411 B1	09-2001	Hentschel, Christian	348/607
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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